

## 120A, 80V N-CHANNEL MOSFET

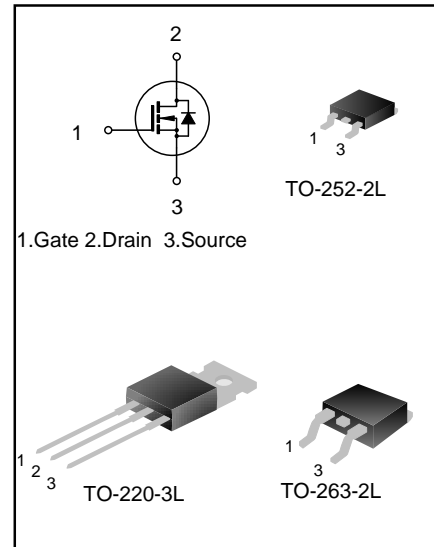
### DESCRIPTION

SVG086R0NT(S)(D) is an N-channel enhancement mode power MOS field effect transistor which is produced using Silan's LVMOS technology. The improved process and cell structure have been especially tailored to minimize on-state resistance, provide superior switching performance.

This device is widely used in UPS, Power Management for Inverter Systems.

### FEATURES

- ◆ 120A, 80V,  $R_{DS(on)(typ.)}=5.0m\Omega @ V_{GS}=10V$
- ◆ Low gate charge
- ◆ Low Crss
- ◆ Fast switching
- ◆ Improved dv/dt capability



### ORDERING INFORMATION

Part No.	Package	Marking	Hazardous Substance Control	Packing Type
SVG086R0NT	TO-220-3L	086R0NT	Pb free	Tube
SVG086R0NS	TO-263-2L	086R0NS	Pb free	Tube
SVG086R0NSTR	TO-263-2L	086R0NS	Pb free	Tape&Reel
SVG086R0NDTR	TO-252-2L	086R0ND	Halogen free	Tape&Reel

**ABSOLUTE MAXIMUM RATINGS (Unless otherwise noted, T<sub>C</sub>=25°C)**

Characteristics	Symbol	Ratings		Unit
		SVG086R0NT/NS	SVG086R0ND	
Drain-Source Voltage	V <sub>DS</sub>	80		V
Gate-Source Voltage	V <sub>GS</sub>	±20		V
Drain Current	I <sub>D</sub>	T <sub>C</sub> =25°C		A
		T <sub>C</sub> =100°C		
Drain Current Pulsed	I <sub>DM</sub>	480		A
Power Dissipation(T <sub>C</sub> =25°C) -Derate above 25°C	P <sub>D</sub>	156	114	W
		1.3	0.9	W/°C
Single Pulsed Avalanche Energy(Note 1)	E <sub>AS</sub>	306		mJ
Operation Junction Temperature Range	T <sub>J</sub>	-55~+150		°C
Storage Temperature Range	T <sub>stg</sub>	-55~+150		°C

**THERMAL CHARACTERISTICS**

Characteristics	Symbol	Ratings		Unit
		SVG086R0NT/NS	SVG086R0ND	
Thermal Resistance, Junction-to-Case	R <sub>θJC</sub>	0.8	1.1	°C/W
Thermal Resistance, Junction-to-Ambient	R <sub>θJA</sub>	62.5	62.0	°C/W

**ELECTRICAL CHARACTERISTICS (Unless otherwise noted,  $T_c=25^\circ\text{C}$ )**

Characteristics	Symbol	Test conditions	Min.	Typ.	Max.	Unit
Drain -Source Breakdown Voltage	$BV_{DSS}$	$V_{GS}=0V, I_D=250\mu A$	80	--	--	V
Drain-Source Leakage Current	$I_{DSS}$	$V_{DS}=80V, V_{GS}=0V$	--	--	1.0	$\mu A$
Gate-Source Leakage Current	$I_{GSS}$	$V_{GS}=\pm 20V, V_{DS}=0V$	--	--	$\pm 100$	nA
Gate Threshold Voltage	$V_{GS(th)}$	$V_{GS}=V_{DS}, I_D=250\mu A$	2.0	--	4.0	V
Static Drain- Source On State Resistance	$R_{DS(on)}$	$V_{GS}=10V, I_D=50A$	--	5.0	6.0	m $\Omega$
Gate Resistance	$R_G$	$f=1MHz$	--	2.2	--	$\Omega$
Input Capacitance	$C_{iss}$	$f=1MHz, V_{GS}=0V, V_{DS}=40V$	--	3896	--	pF
Output Capacitance	$C_{oss}$		--	520	--	
Reverse Transfer Capacitance	$C_{rss}$		--	25	--	
Turn-on Delay Time	$t_{d(on)}$	$V_{DD}=40V, V_{GS}=10V, R_G=3.5\Omega,$ $I_D=10A$ (Note 2,3)	--	22	--	ns
Turn-on Rise Time	$t_r$		--	35	--	
Turn-off Delay Time	$t_{d(off)}$		--	56	--	
Turn-off Fall Time	$t_f$		--	19	--	
Total Gate Charge	$Q_g$	$V_{DD}=64V, V_{GS}=10V, I_D=50A$ (Note 2,3)	--	66	--	nC
Gate-Source Charge	$Q_{gs}$		--	25	--	
Gate-Drain Charge	$Q_{gd}$		--	17	--	

**SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS**

Characteristics	Symbol	Test conditions	Min.	Typ.	Max.	Unit
Continuous Source Current	$I_S$	Integral Reverse P-N Junction	--	--	120	A
Pulsed Source Current	$I_{SM}$	Diode in the MOSFET	--	--	480	
Diode Forward Voltage	$V_{SD}$	$I_S=50A, V_{GS}=0V$	--	--	1.4	V
Reverse Recovery Time	$T_{rr}$	$I_S=30A, V_{GS}=0V,$	--	47	--	ns
Reverse Recovery Charge	$Q_{rr}$	$dI/dt=100A/\mu s$ (Note 2)	--	0.06	--	$\mu C$

**Notes:**

- $L=0.5mH, I_{AS}=35A, V_{DD}=50V, R_G=25\Omega,$  starting  $T_J=25^\circ\text{C}$ ;
- Pulse Test: Pulse width  $\leq 300\mu s,$  Duty cycle  $\leq 2\%$ ;
- Essentially independent of operating temperature.

TYPICAL CHARACTERISTICS

Figure 1. Output Characteristics

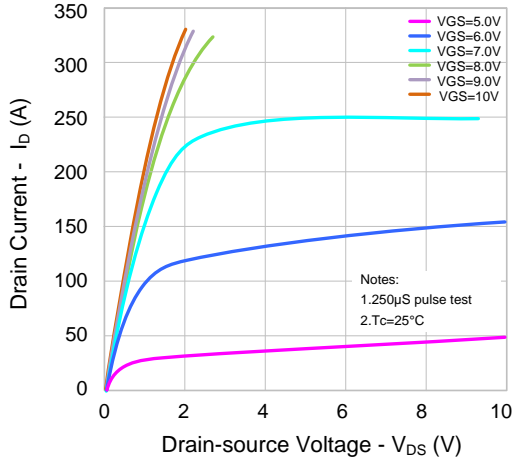


Figure 2. Transfer Characteristics

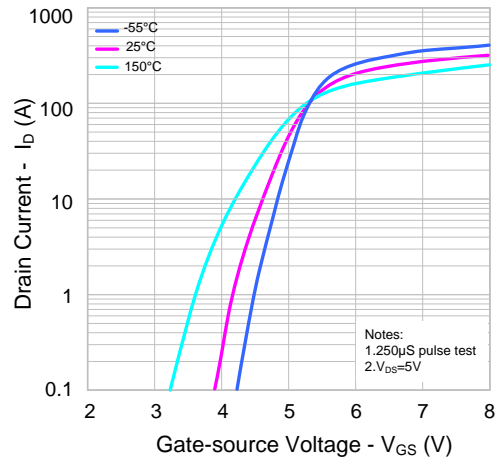


Figure 3. On-resistance vs. Drain Current

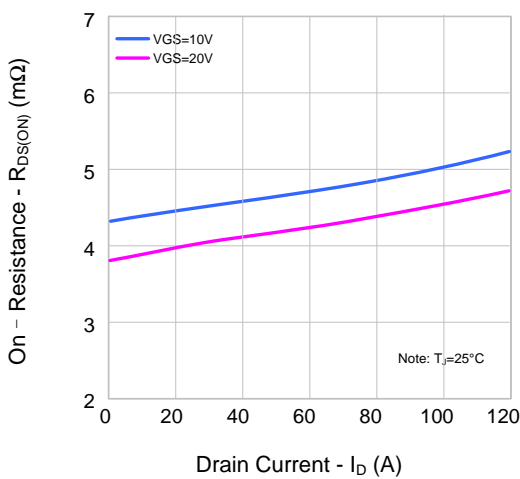


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

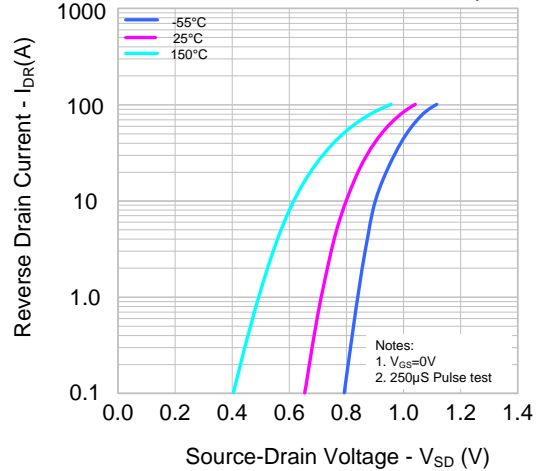


Figure 5. Capacitance Characteristics

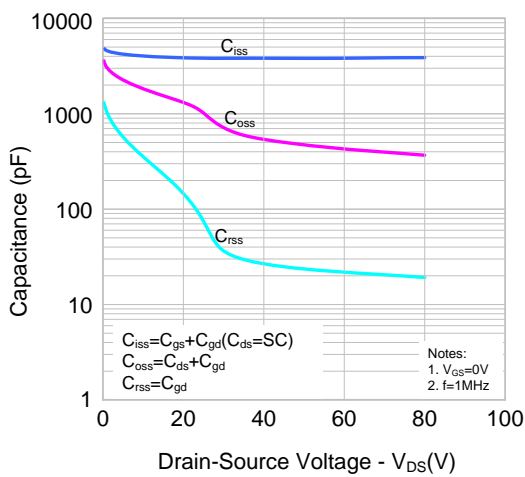
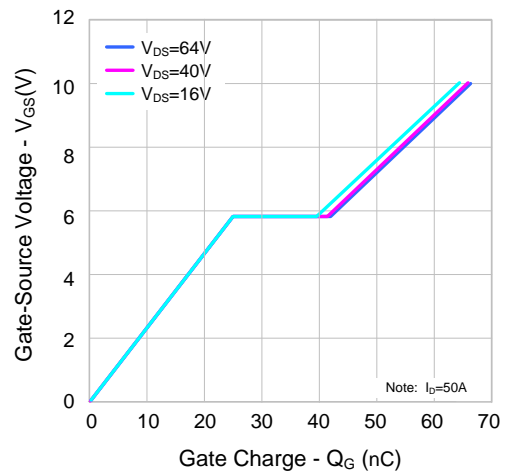
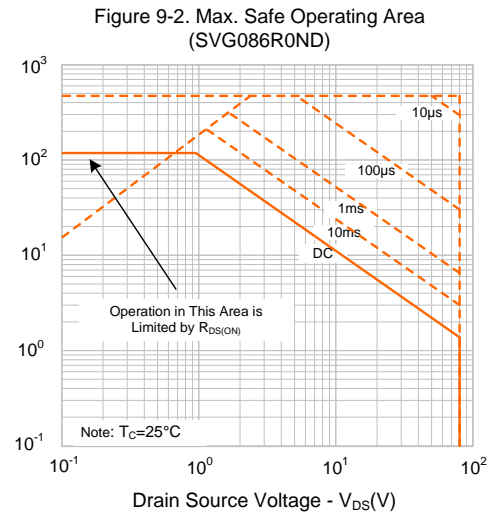
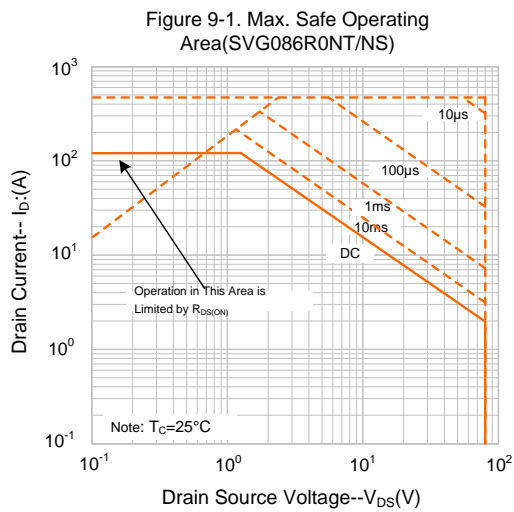
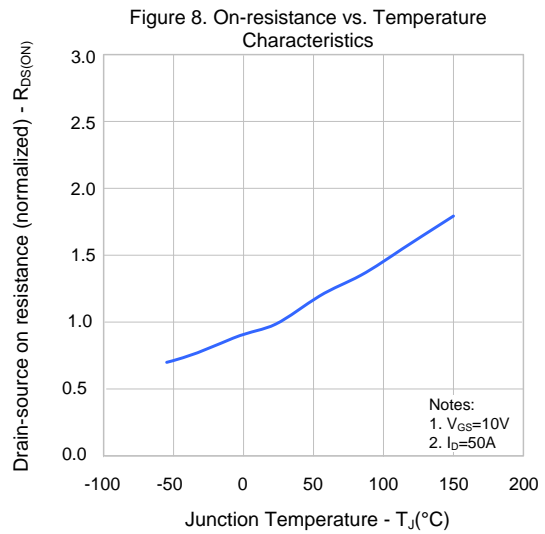
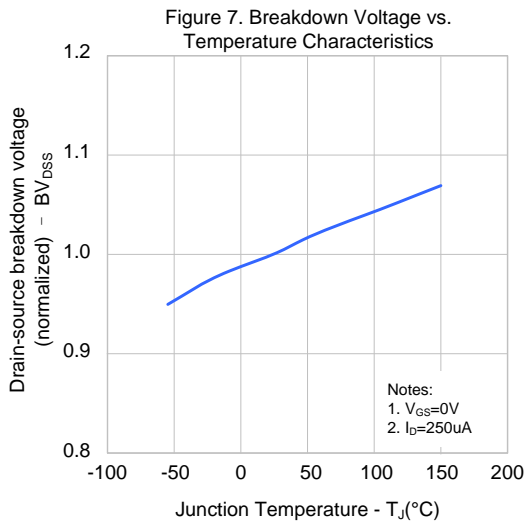


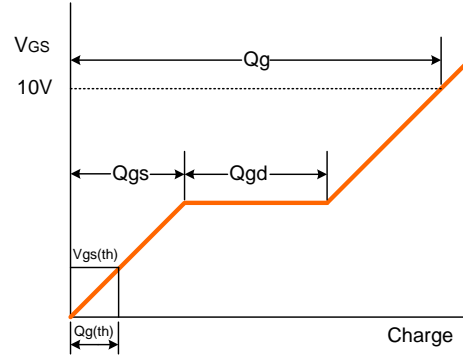
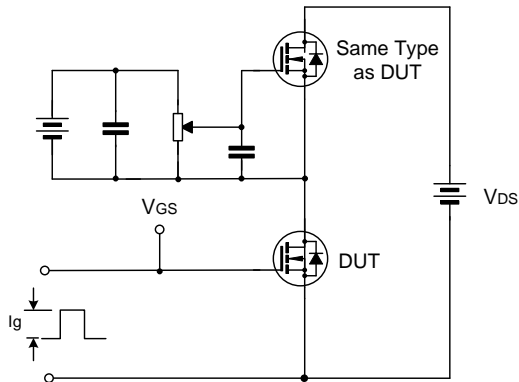
Figure 6. Gate Charge



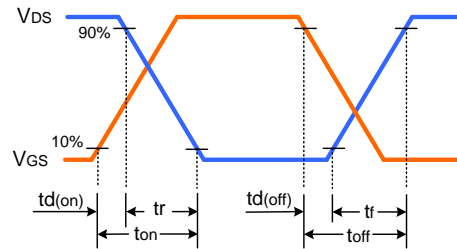
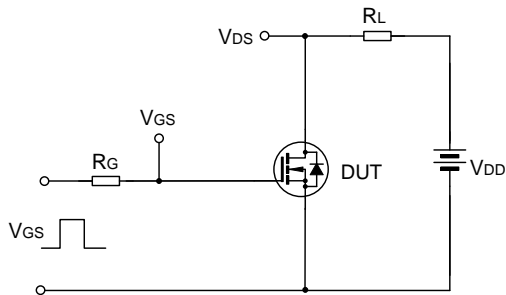
**TYPICAL CHARACTERISTICS(continued)**



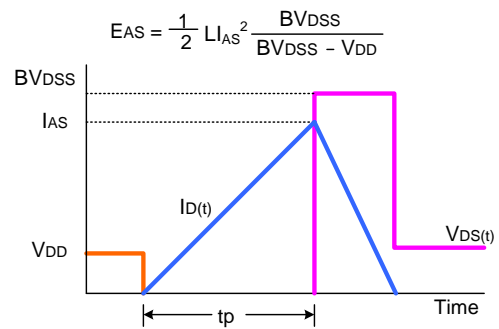
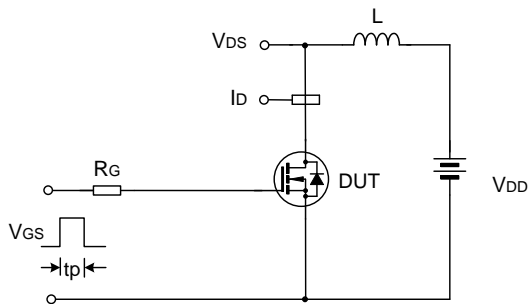
**TYPICAL TEST CIRCUIT**



Gate Charge Test Circuit & Waveform



Resistive Switching Test Circuit & Waveform

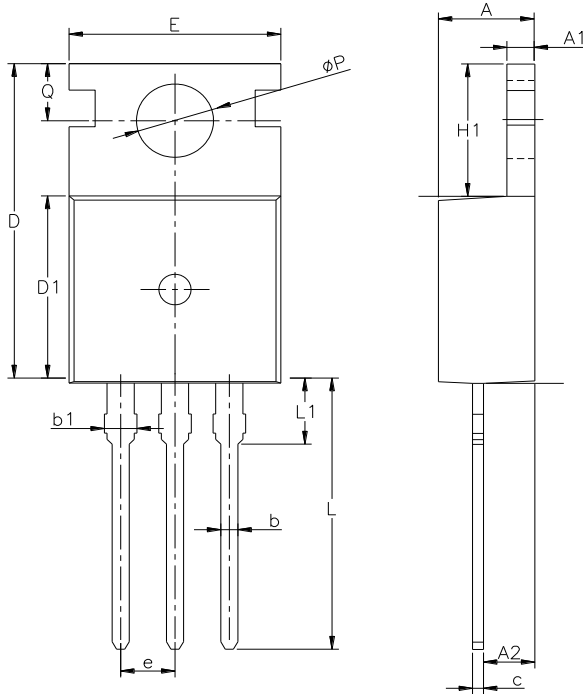


Unclamped Inductive Switching Test Circuit & Waveform

PACKAGE OUTLINE

TO-220-3L

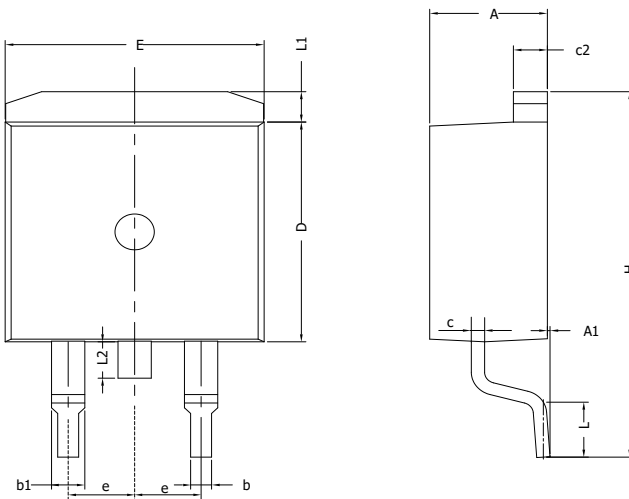
UNIT: mm



SYMBOL	MIN	NOM	MAX
A	4.30	4.50	4.70
A1	1.00	1.30	1.50
A2	1.80	2.40	2.80
b	0.60	0.80	1.00
b1	1.00	—	1.60
c	0.30	—	0.70
D	15.10	15.70	16.10
D1	8.10	9.20	10.00
E	9.60	9.90	10.40
e	2.54BSC		
H1	6.10	6.50	7.00
L	12.60	13.08	13.60
L1	—	—	3.95
phi P	3.40	3.70	3.90
Q	2.60	—	3.20

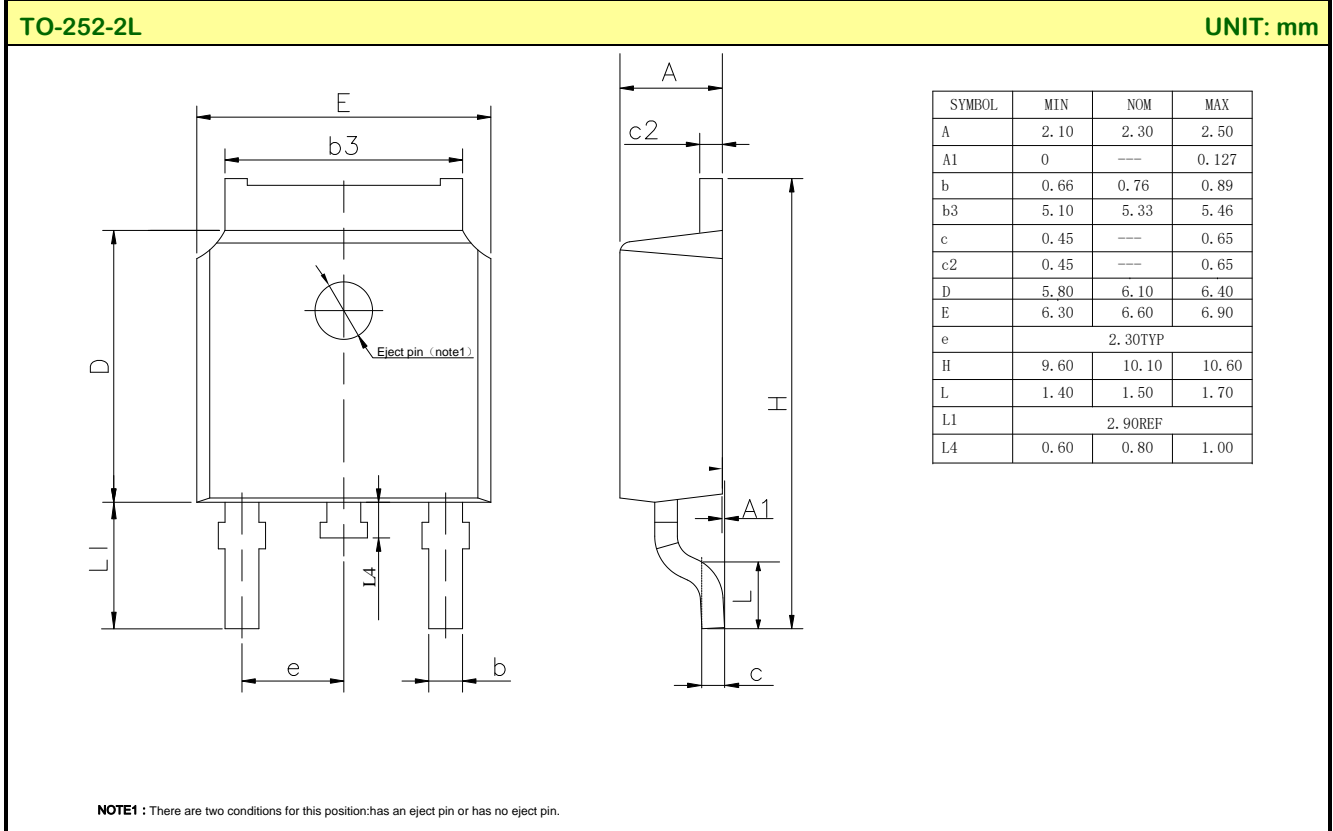
TO-263-2L

UNIT: mm



SYMBOL	MIN	NOM	MAX
A	4.30	4.57	4.72
A1	0	0.10	0.25
b	0.71	0.81	0.91
c	0.30	---	0.60
c2	1.17	1.27	1.37
D	8.50	---	9.35
E	9.80	---	10.45
e	2.54BSC		
H	14.70	---	15.75
L	2.00	2.30	2.74
L1	1.12	1.27	1.42
L2	---	---	1.75

## PACKAGE OUTLINE



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Rev.: **1.3**

Revision History:

1. Update Electrical schematic and typical test circuit
- 

Rev.: **1.2**

Revision History:

1. Add TO-252-2L
- 

Rev.: **1.1**

Revision History:

1. Add TO-263-2L
- 

Rev.: **1.0**

Revision History:

1. First release
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